

47 CFR Part 15 Subpart B, ICES-003

Electromagnetic Compatibility Test Report

For

Tablet

ORDER NO.: 200511K004 REPORT NO.: FC200511K004 R1 ISSUED DATE: 15, July, 2020 MODEL NO.: SM-T970

Samsung Electronics Co.,Ltd.

129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Republic of Korea



Certificate #4068.03

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Test Report Details

Test Report No.	FC200511K004 R1							
Tests Performed By:	Bureau Veritas CPS ADT Korea Ltd. Innoplex No.2 106, Sinwon-ro 306, Yeongtong-gu, Suwon-si, Gveonggi-do, 16675, Republic of Korea							
Test site:	Bureau Veritas CPS ADT Korea Ltd. HeungAn-daero 49, DonAn-gu, Anyang-si, Gyeonggi-do, 11419, Republic of Korea							
Applicant:	Samsung Electronics Co.,Ltd. 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Republic of Korea							
Product Type:	Tablet							
Model Number:	SM-T970							
FCC ID	A3LSMT970							
ISED Certification Number:	649E-SMT970							
Product standards:	47 CFR Part 15 Subpart B, ICES-003 ANSI C63.4-2014							
Classification	Class B							
Sample Serial Number:	R32N5018PPL							
Sample Receive Date:	08, June, 2020							
Testing Start Date:	08, June, 2020							
Date Testing Complete:	18, June, 2020							
Overall Results:	Complied							

This test report apply only to the specific samples tested under stated test conditions. All samples tested were in good operating condition throughout the entire test program. It is the manufacturer's responsibility to assure that additional production units of this model are manufactured with identical electrical and mechanical components Bureau Veritas CPS ADT Korea Ltd. shall have no liability for any deductions, inferences or generalizations drawn by the client or others from Bureau Veritas CPS ADT Korea Ltd. issued reports.

Report Number Model Number FC200511K004 R1 SM-T970



RELEASE CONTROL RECORD

	DATE HOUGED
)riginal release	29, June, 2020
dd the test condition (Section 3.5.2)	15, July, 2020
	riginal release dd the test condition (Section 3.5.2)

This project has been tested and verified to comply with the requirements of *Bureau Veritas CPS ADT Korea Ltd.* Therefore, this certificate is issued.

PREPARED BY : , DATE : 15. July, -Bob Kim / Senior Engineer **APPROVED BY :** Wan Kim / Senior Manger



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1. EMC Result Conclusion (With Justification)

The following tests were performed on a sample submitted for evaluation of compliance with 47 CFR Part 15.107(b) / 47 CFR Part 15.109 (b) Class B, ICES-003								
Test requirements	Standard	Standard Results						
Emissions								
Conducted RF Emissions		Pass	Complied					
Radiated RF Emissions	ANSI 003.4	Pass	Complied					
We tested the Tablet, Model: SM-T970, to determine if it was in compliance with the relevant standards as marked on the EMC Verification Summary. We found that the unit met the requirement of 47 CFR Part 15 Subpart B, ICES-003 / ANSI C63.4-2014 standards when tested as received. The production units are required to conform to the initial sample as received when the units are placed on the market.								

2. General Product Description

2.1 Equipment Description

The Equipment under Test (EUT) is the Tablet. The test data contained in this report pertains only to the emissions due to the digital circuitry of the EUT.

2.2 Technical Data

This device contains the following capabilities.

802.11 b/g/n/ax WLAN, 802.11 a/n/ac/ax UNII, 2.4 GHz/5 GHz Wi-Fi Direct, Wi-Fi RSDB, Bluetooth (EDR, LE), WPT(for S-pen Charging).



3. Test Condition

3.1 Ancillary Equipment

Use*	Product Type	Manufacturer	Model	FCC ID & Certification Number
EUT	Tablet	Samsung Electronics Co.,Ltd.	SM-T970	A3LSMT970 649E-SMT970
AE	TRAVEL ADAPTER	SOLUM VINA COMPANY LIMITED	EP-TA200	-
AE	Earphone	Bujeon Electronics Inc.	GHSS028-K7	-
AE	Keyboard	Samsung Electronics Co.,Ltd.	EF-DT970	-
AE	S-Pen	WACOM	EJ-PT870	A3LEJPT870
AE	S-Pen	WACOM	EJ-PT870	A3LEJPT870
AE	Micro SD Card	Samsung Electronics Co.,Ltd.	EVO Plus (64G)	DoC
AE	Notebook Computer	Samsung Electronics Co.,Ltd.	NT950XBV	DoC
AE	AC/DC ADAPTER	Dongguan Yingju Power Co., Ltd.	PSCV650105A	DoC
AE	Monitor	HONHFUJIN PRECISION ELECTRONICS CO., LTD.	D18225WT0	DoC
* Note to Test)	: EUT - Equipment Unde	er Test, AE - Auxiliary/Associated Equ	uipment, SIM - S	imulator (Not Subjected

3.2 Input/Output Ports

Port #	Name	Type*	Cable (m) Max. >3 m	Cable Shielded	Comments		
1	TRAVEL ADAPTER	DC	1.0	Shielded	Power (Mode # C1, C2, R1)		
2	Notebook Computer	DC, I/O	1.0	Shielded	Power, Data Link (Mode # C4, R5)		
3	Monitor	I/O	1.8	Shielded	Audio, Video Out (Mode #R4)		
4	Earphone	I/O	1.5	None-Shielded	Audio Out (Mode #R4)		
5	S-Pen	I/O	-	-	Wireless Charging (Mode #C3, R3)		
6	S-Pen	I/O	-	-	EMR Touch (Mode #C3, R3)		
7	Keyboard	I/O	-	-	Pogo Pin (Mode #C1, C2, R1, R2)		
8	Micro SD Card	I/O	-	-	External memory (Mode #C4, R5)		
* Note: * AC = AC Power Port, DC = DC Power Port, N/E = Non-Electrical, I/O = Signal Input or Output Port (Not Involved in Process Control), TP = Telecommunication Ports							



3.3 EUT Internal Operating Frequencies

Frequency (MHz)	requency (MHz) Description		Description	
5 825	Wi-Fi	-	-	

3.4 Power Interface

Mode #	Voltage (V)	Current (A)	Power (W)	Frequency (DC/AC-Hz)	Comments
Rated	3.85	-	-	DC	EUT
1	120	-	-	AC-60	TRAVEL ADAPTER
2	120	-	-	AC-60	Notebook Computer
3	3.85	-	-	DC	Internal Battery

3.5 Modes of Description

3.5.1 Conducted Emission Operating Mode

Mode #	Description
C1	Camera(Rear) + Charging(TA) + Keyboard(Pogo pin)
C2	Camera(Front) + Charging(TA) + Keyboard(Pogo pin)
C3	Video + Audio playback from internal memory data + EMR Touch Solution(S-Pen) + Wireless Charging (S-Pen) + Charging(TA)
C4	USB Data Communication with PC (From external memory data)

3.5.2 Radiated Emission Operating Mode

Mode #	Description
R1	Camera(Rear) + Charging(TA) + Keyboard(Pogo pin)
R2	Camera(Front) + Keyboard(Pogo pin)
R3	Video + Audio playback from internal memory data + EMR Touch Solution(S-Pen) + Wireless Charging (S-Pen) + Earphone
R4	Video + Audio playback from internal memory data + Display out(Direct DP Cable)
R5	USB Data Communication with PC (From external memory data)

Note1) The EUT was investigated in three orientations and the worst orientation reported.



3.6 Configuration















4. Test Condition and Results

4.1 Conducted Emissions

	TEST: Limits of mains terminal disturbance voltage								
Method	The AM referen other u was co measu	AMN placed 0.8 m from the boundary of the unit under test and bonded to a ground ence plane. This distance was between the closest points of the AMN and the EUT. All r units of the EUT and associated equipment were at least 0.8 m from the AMN. All power connected to the system through Artificial Mains Network (AMN). Conducted voltage surements on mains lines were made at the output of the AMN.							
				Laboratory Ambient Temperature				23.2 °C	
Farameters recorded during the test		.001	Relative Humidity			44.2 %			
Frequency range on each side of line Measurement Point						easurement Point			
Fully configured sample scanned over the following frequency range			over	150 kHz to 30 MHz		AC main power port			
				Limits – Class B					
Frequency	(MH-)			Limit (dBµV)					
Trequency	(101112)	Quasi-Peak		Result		Average		Result	
0.15 to (0.5	66 to 56	i	Pass		56 to 46		Pass	
0.5 to :	5	56		Pass		46		Pass	
5 to 30	C	60		Pass		50		Pass	
Conducted Emissions EUT Configuration Settings									
Power Interface Mode #			EUT Operation Mode # EUT		EUT (Configurations Mode #			
(See Section 3.4)			(See Section 3.5)		(See Section 3.6)				
	1,2			C1, C2, C3, C4 C1, C2, C3, C4			C2, C3, C4		

Test Equipment Used									
Description Manufacturer Model Identifier Cal. Date Cal. I									
LISN	R&S	ENV216	102437	2019.12.26	2020.12.26				
EMI Test Receiver	R&S	ESR	102529	2019.12.27	2020.12.27				
SoftWare	R&S	EMC 32	Ver. 10.50.40	-	-				

Note1) Formula

Final Value (QP and/or CAV) = Reading Value (QP and/or CAV) + Corr. (LISN Insertion Loss + Cable Loss) Margin (QP and/or CAV) = Limit – Final Value (QP and/or CAV) QP = Quasi-Peak, CAV = CISPR-Average, Corr. = Correction Factor



Table 1. Conducted emission Test data



Note1) Two graphs measured for both Live (L1) and Neutral (N) of the LISN are combined into one graph.



Operation Mode #2



Note1) Two graphs measured for both Live (L1) and Neutral (N) of the LISN are combined into one graph.

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Operation Mode #3 100 90 80 70 60 Level in dBµV 50 40 30 20 10 0 300 400 500 800 1M 2M 3M 4M 5M 6 8 10M 30M 150k 20M Frequency in Hz Final Result Frequency QuasiPeak CAverage Limit Margin Bandwidth Line Corr. (dBµV) (MHz) (dBµV) (dBµV) (dB) (kHz) (dB) 0.167559 46.54 65.08 18.54 9.000 N 10.1 0.167559 28.79 55.08 26.29 9.000 N 10.1 33.87 0.220235 62.81 28.94 9.000 Ν 9.8 17.58 35.23 9.000 N 9.8 0.220235 52.81 15.55 40.45 56.00 9.000 10.0 4.061228 L1 29.95 4.061228 46.00 16.05 9.000 L1 10.0 42.64 9.000 L1 4.258765 56.00 13.36 10.0 4.258765 30.34 46.00 15.66 9.000 L1 10.0 4.438743 31.17 46.00 14.83 9.000 L1 10.0 42.30 56.00 4.438743 13.70 9.000 L1 10.0 30.26 10.0 4.508978 46.00 15.74 9.000 L1 4.508978 42.27 56.00 13.73 9.000 L1 10.0 30.52 9.000 L1 46.00 15.48 10.0 4.658228 41.78 4.658228 56.00 14.22 9.000 L1 10.0 60.00 9.000 10.1 9.135728 39.26 20.74 L1 27.73 50.00 22.27 9.000 L1 10.1 9.135728 13.262052 40.08 60.00 19.92 9.000 L1 10.3 29.11 50.00 20.89 9.000 L1 10.3

Note1) Two graphs measured for both Live (L1) and Neutral (N) of the LISN are combined into one graph.

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Note1) Two graphs measured for both Live (L1) and Neutral (N) of the LISN are combined into one graph.

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4.2 Radiated Emissions

TEST: Limits for radiated disturbance					
Method	Measurements were made in a 10-meter semi-anechoic chamber that complies to ANSI C63.4. Preliminary (peak) measurements were performed at an antenna to EUT separation distance of 10-meter. The EUT was rotated 360° about its azimuth with the receive antenna located at 1, 2, 3 and 4 meter heights in both horizontal and vertical polarities. Final measurements (quasi-peak or average as noted) were then performed by rotating the EUT 360° and adjusting the receive antenna height from 1 to 4 meters. All frequencies were investigated in both horizontal and vertical antenna polarity, where applicable.				
Parameters recorded during the test	Laboratory Ambient Temperature		(21.4 - 23.1) °C		
	Relative Humidity		(45.3 - 46.3) %		
	Frequency range		Measurement Point		
Fully configured sample scanned	30 MHz – 1 000 MHz		3 meter measurement distance		
over the following frequency range	1 000 MHz – 30 000 MHz		3 meter measurement distance		
Limits – Class B					
Frequency (MHz)	Limit (dBµV/m)				
Below 1 GHz	Quasi-Peak		Results		
30 to 88	4	40		Pass	
88 to 216	43.5		Pass		
216 to 960	46		Pass		
960 to 1 000	54		Pass		
Above 1 GHz	Average Peak		Result		
1 000 to 30 000	54	74	Pass	Pass	
1 000 to 30 000	54 EUT Configurati	74 ion Settings:	Pass	Pass	
1 000 to 30 000 Power Interface Mode #	54 EUT Configuration	74 ion Settings: n Mode #	Pass EUT Configura	Pass tions Mode #	
1 000 to 30 000 Power Interface Mode # (See Section 3.3)	54 EUT Configuration EUT Operation (See Section	74 ion Settings: in Mode # on 3.4)	Pass EUT Configura (See Sect	Pass tions Mode # tion 3.5)	



Test Equipment Used						
Description	Manufacturer	Model	Identifier	Cal. Date	Cal. Due	
EMI Test Receiver	R&S	ESW44	101812	2020.02.20	2021.02.20	
Trilog Antenna (with 6 dB ATT.)	Schwarzbeck	VULB 9163	01199	2019.04.03	2021.04.03	
Horn Antenna	R&S	HF907	102773	2020.02.10	2021.02.10	
Wideband Horn Antenna	R&S	QMS-00880	21911	2020.03.23	2021.03.23	
Signal Conditioning Unit	R&S	SCU08F2	08400016	2019.12.30	2020.12.30	
Pre-Amplifier	Miteq	LNAS-55-010 01800-22-10P	2139542	2020.04.07	2021.04.07	
Pre-Amplifier	Miteq	JS44-180040 00-33-8P	2142087	2020.04.07	2021.04.07	
SoftWare	R&S	EMC 32	Ver. 10.35.10	-	-	

Note1) Formula

Final Value (PK and/or QP and/or CAV) = Reading Value (PK and/or QP and/or CAV) + Corr. (Antenna Factor + Cable Loss + Distance Correction - Amplifier Gain)

Margin (PK and/or QP and/or CAV) = Limit – Final Value (PK and/or QP and/or CAV)

PK = Peak, QP = Quasi-Peak, CAV = CISPR-Average, Corr. = Correction Factor

Note2) Distance (Antenna to Centre of Turntable), Antenna Height

Below 1 GHz, Distance = 3 m, Antenna Height = (1 to 4) m

Above 1 GHz, Distance = 4.5 m, Antenna Height (Considering size of EUT) = (1 to 4) m

Distance Correction = 20 log (d2 (m) / d1 (m)) = 20 log (4.5 / 3) = 3.5



Table 2. Radiated emission Test data











<u>Note 2</u>) Emission was scanned 18 GHz to 30 GHz; No emissions were detected above the noise floor which was at least 20 dB below the spec**ifi**cation limit.



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Note 2) Emission was scanned 18 GHz to 30 GHz; No emissions were detected above the noise floor which was at least 20 dB below the specification limit.











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Note1) Two graphs measured for both Vertical and Horizontal of the Antenna are combined into one graph.

<u>Note 2</u>) Emission was scanned 18 GHz to 30 GHz; No emissions were detected above the noise floor which was at least 20 dB below the spec**ifi**cation limit.













<u>Note 2</u>) Emission was scanned 18 GHz to 30 GHz; No emissions were detected above the noise floor which was at least 20 dB below the specification limit.



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<u>Note 2</u>) Emission was scanned 18 GHz to 30 GHz; No emissions were detected above the noise floor which was at least 20 dB below the specification limit.



Appendix A. Test site accreditations

Certificate	Nation	Agency	Code	Remark
Accreditation	USA	A2LA	4068.03	31 July, 2019
Accreditation	KOREA	RRA	KR0158	10 January, 2020
Registration	Japan	VCCI	4013	17 February,2020
Accreditation	USA MRA	FCC	KR0158, 666061	17 March, 2020
Accreditation	CANADA MRA	ISED	KR0158, 25944	17 March, 2020
Accreditation	Vietnam MRA	MIC	KR0158	20 April, 2020

Quality control in the testing laboratory is implemented as per ISO/IEC 17025 which is the "General requirements for the competent of calibration and testing laboratory".

Appendix B. Measurement Uncertainties

Test Item	Measurement uncertainty			
Conducted emission	2.62 dB			
Radiated emission (16 Below)	4.04 dB			
Radiated emission (16//z Over)	5.10 dB			
Note 1: Measurement uncertainty is calculated in according with CISPR 16-4-2: 2011+A1:2014+A2:2018 The measurement uncertainty is given with a confidence of 95 % with the coverage factor, k=2.				